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Texas Instruments Enhanced Plastic Products Reliability Report

(Subject To Attached Disclaimers)

Device Type/Device Family: TPS77401MDGKREP

Package Type: 8 Pin VSSOP (Ti Designator DGK)

Wafer Fabrication Facility: Dallas Linear Assembly/Test Facility: HANA Thailand

Compiledd: 10/2006

Biased Life Test

Test Method: JESD22-A108 Test Condition: 150°/500 hours

Sample Size: 20853

Rejects: 20(Unverified)

Activation Energy (eV): .7

Equivalent Device Hours: 1155.7E6 Failure Rate (FIT)*: 18.9

*Derated to +55°C with a 60% Confidence Level

Note: Data for EP product is specific to device technology and foundry. For this reason the FIT rate above may differ from Ti's external web page. This does not reflect a difference in quality but only a difference in sample size.

Package Related Tests

<u>Description</u>	<u>Condition</u>	Referenced Method	Sample Size/Rejects	
Biased Humidity or HAST	85°C / 85% / 1000 hours or 130°C / 85% / 96 hours	JESD22-A101 JESD22-A110	385/0	*
Autoclave	121 °C @ 2 atmospheres absolute for 96 hours	JESD22-A102	462/0	*
Temperature Cycle	-65 °C to +150 °C non-biased for 1000 cycles	JESD22-A104	616/0	*
High Temp Storage	170 °C / 420 hours	JESD22-A103-A	693/0	*

^{*} Preconditioning per JEDEC Std. 22, Method A112/A113

^{**} This device has been qualified to the elevated standard of 250 Hrs 130/85 HAST (Highly Accelerated Stress Test) at SS 231/0. This qualification level surpasses JEDEC requirements.

Initial Product Qualification

The subject Enhanced Plastic device, device family, and/or package family have passed Texas Instruments product qualification as follows:

Description	Condition	Sample Size	Referenced Method	
Electrical Characterization	TI Data Sheet	50 units/lot	N/A	
Electrostatic Discharge Sensitivity	HBM MM	3 units/voltage	EIA/JESD22-A114 EIA/JESD22-A115	
Latch-up	Per Technology	5/0 units/lot	EIA/JESD78	
Physical Dimensions	TI Data Sheet	5/0	EIA/JESD22- B100	
Thermal Impedance	Theta-JA on board	Per Pin-Package	EIA/JESD51	
Bias Life Test	125°C / 1000 hours or equivalent	116/0	JESD22-A108	*
Biased Humidity	85°C / 85% / 1000 hours	77/0	JESD22-A101	*
HAST	or 130°C / 85% / 96 hours		JESD22-A110	
Autoclave	121 °C @ 2 atmospheres absolute for 96 hours	77/0	JESD22-A102	*
Temperature Cycle	-65 °C to +150 °C non-biased for 1,000 cycles	77/0	JESD22-A104	*
Solder Heat	260 °C for 10 seconds	22/0	JESD22-B106	
Resistance to Solvents	Ink symbol only	12/0	JESD22-B107	
Solderability	Condition A (steam age for 8 hours)	22/0	ANSI/J-STD-002-92	
Flammability	Method A / Method B	5/0	UL-1964	
Bond Strength	-	76/0 wires	ASTM F-459	
Die Shear	-	5/0	MIL-STD-883 Method 2019	
High Temp Storage	150 °C / 1,000 hours	45/0	JESD22-A103-A	*
Moisture Sensitivity	Surface Mount Only	12/0	J-STD-020-A * Precondition performed	

Supplemental Device Characteristics

Device Type:

Die Revision: A Assembly Site: HANA Thailand

Master Die: BLBDPS77201AW Package Type: VSSOP

Wafer Fab: DFAB Pin Count: 8

Fab Technology: LinBiCMOS Mold Compound: SUMITOMO EME-G600

Fab Process: LBC3S Mount Compound: ABLESTIK 2200D (GRN)

Process Code: N/A Bond: 1 Mil Au

Passivation: Nitride Lead Composition: Cu

Metal 1: AlSi(1%)Cu(0.5%) Lead Finish: NiPdAu

Metal 2: AlSi(1%)Cu(0.5%) Die Size: 50 X 80 Mils

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